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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO. 0862.1463

Sheet 1 of 1 APPLICATION NO. 09/890,143

INFORMATION DISCLOSURE STATEMENT

FIRST NAMED INVENTOR

Masaki YAMAMOTO

GROUP ART UNIT

2882

(Use several sheets if necessary)

July 26, 2001

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA	5,935,737	8/10/1999	Yan			
	AB	5,085,957	2/4/1992	Hosono			
	AC					- <u>-</u>	
	AD						
	AE					,	
	AF						

FOREIGN PATENT DOCUMENTS

 т	T	T	T		
	DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
AG	EP 0 279 670	8/24/1988	Europe		
АН	4-204603	7/27/1992	Japan		Х
AI	6-180399	6/28/1994	Japan		Х
AJ	11-23796	1/29/1999	Japan		Х
AK	63-211130	9/2/1988	Japan		Х
AL					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)				
AN	Hawryluk et al., "Repair of Opaque Defects on Reflection Masks for Soft X-Ray Projection Lithography", J. Vac. Sci. Technol. B 10(6), Nov/Dec. 1992, pgs. 3182-3185.			

EXAMINER		DATE CONSIDERED	
/G	hih-Cheng Kao/		08/18/2008

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.